

## CORRECTION

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## Correction: Towards improved precision in the quantification of surface-enhanced Raman scattering (SERS) enhancement factors: a renewed approach

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[www.rsc.org/analyst](http://www.rsc.org/analyst)Correction for 'Towards improved precision in the quantification of surface-enhanced Raman scattering (SERS) enhancement factors: a renewed approach' by Arumugam Sivanesan *et al.*, *Analyst*, 2015, DOI: 10.1039/c4an01778a.Regarding Fig. 1–3, the following should appear in the **Acknowledgements** section:

Figures and excerpt reprinted from *Electrochemistry Communications*, A. Sivanesan, W. Adamkiewicz, G. Kalaivani, A. Kamińska, J. Waluk, R. Hołyst and E. L. Izake 'Electrochemical pathway for the quantification of SERS enhancement factor', 2014, **49**, 103–106, with permission from Elsevier.

The Royal Society of Chemistry apologises for these errors and any consequent inconvenience to authors and readers.

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